S	ea	rch	No	otes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/066,693	NAKAZAWA ET AL.	
Examiner	Art Unit	

2836

Danny Nguyen

SEARCHED					
Class	Subclass	Date	Examiner		
361	502	3/7/2006	DN		
	503				
	512				
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
see	3/7/2006	DN		
attached				
	Subclass see	Subclass Date see 3/7/2006		

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Update East Search USPGPUB, USPAT, DERWENT, EPO, JPO, IBM	3/7/2006	DN
Interference search 29/25.03,429/185,189	3/7/2006	DN